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Bib Data Sheet

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|--|---|----------------------------------|--|--|----------------------------------|
| SERIAL NUMBER 09/697,305 | FILING DATE 10/27/2000 RULE - | CLASS 324 | GROUP ART UNIT 2858 | ATTORNEY DOCKET NO. YMOR:186 | |
| APPLICANTS Takaki Yoshida, Osaka, JAPAN; Reisuke Shimoda, Osaka, JAPAN; ✓ | | | | | |
| ** CONTINUING DATA ***** ✓ | | | | | |
| ** FOREIGN APPLICATIONS ***** JAPAN 11-307872 10/29/1999 ✓ | | | | | |
| IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 12/21/2000 - | | | | | |
| Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a-d) conditions <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after met Allowance Verified and Acknowledged <input checked="" type="checkbox"/> <i>[Signature]</i> Initials | | STATE OR COUNTRY JAPAN | SHEETS DRAWING 50 ✓ | TOTAL CLAIMS 52 ✓ | INDEPENDENT CLAIMS 5 ✓ |
| ADDRESS PARKHURST & WENDEL, LLP 1421 Prince Street, Suite 210 Alexandria, VA 22314 | | | | | |
| TITLE Fault detecting method and layout method for semiconductor integrated circuit ✓ | | | | | |
| FILING FEE RECEIVED 1410 | FEES: Authority has been given in Paper No. <u>1</u> to charge/credit DEPOSIT ACCOUNT No. <u>16-0331</u> for following: | | <input checked="" type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit | | |